## Particle size measurement <br> 03/11/2006 A. Trunschke

## Further reading

T. Allen, Particle Size Measurement, Volume 1, Powder sampling and particle size measurement methods, Chapmann \& Hall, London 1997.
C. Bernhardt, Particle Size Analysis, Classification and Sedimentation methods, Chapmann \& Hall, London 1994.
J.P.M. Syvitski (Ed.), Principles, methods, and application of particle size analysis, Cambridge University Press, Cambridge 1991.
J.B.J. Berne, R. Pecora, Dynamic Light Scattering, John Wiley \& Sons, Inc. NY, 1976.
H.-D. Dörfler, Grenzflächen- und Kolloidchemie, VCH, Weiheim, 1994.
G. Ertl, H. Knözinger, J. Weitkamp (Eds.), Handbook of Heterogeneous Catalysis, VCH, Weinheim, 1997.


## Outline

1. Definitions
2. Classification of methods
3. Particles of an active phase - supported metal particles
3.1. Chemisorption

### 3.2. LBA

### 3.3. EM

4. Dispersions, colloids, bulk catalysts
4.1. Sieving
4.2. Sedimentation
4.3. Light scattering
4.4. Acoustic methods
4.5. SAXS
5. General remarks and recommendations

Particle
small object of any size from the macroscopic scale ( $10^{-3} \mathrm{~m}$ ) to the atomic scale ( $10^{-10} \mathrm{~m}$ )

| Continuous <br> phase | Disperse <br> phase | Denomination | Examples / applications |
| :--- | :--- | :--- | :--- |
| Gaseous | Solid | Aerosol | Synthesis of oxides |
| Liquid | Liquid | Emulsion | Extraction |
| Liquid | Solid | Suspension <br> Sol <br> Gel | Precipitation <br> Sol-gel chemistry <br> Colloidal metals |
| Solid | Gaseous | Xerogel, <br> Aerogel, <br> Foam | Supports, bulk catalysts (zeolites) |
| Solid | Solid | Alloy <br> Dispersed <br> metals | Pt-Rh gauze for $\mathrm{NH}_{3}$ oxidation <br> Pt-Sn/Al $\mathrm{O}_{3}$ |

Particle small object of any size from the macroscopic scale $\left(10^{-3} \mathrm{~m}\right)$ to the atomic scale $\left(10^{-10} \mathrm{~m}\right)$



Heterogeneous catalysis
Sasol aluminas of different particle size
http://www.sasoltechdata.com/alum ina_group.asp

## Primary particles of catalyst supports

Metal


Crystallite


Primary particles
small single crystal primary catalyst particles could be formed by one or more crystallites


Secondary


Grains, shaped catalysts

CuZn hydroxycarbonate precipitated


Agglomerates of $\mathrm{MoVTeNbO}_{x}$ crystals (M1) spray-dried


## Particle size catalyst particles present a size distrilbution



Complications
$\rightarrow$ Shape is not spherical
$\rightarrow$ Shape is not homogeneous

Size distribution of Cu particles in a methanol synthesis catalyst

Nanoparticles
Very small particles ( $1-20 \mathrm{~nm}$ ) of an active component dispersed on high-surface-area solids

$\mathrm{Ag}-\mathrm{TiO} 2-40$

## Classification of methods - Particle diversity

Embedded Cu particles in catalysts for methanol synthesis


Bulk catalyst precursor


Bulk catalysts

$\mathrm{MoV}_{0.3} \mathrm{Te}_{0.23} \mathrm{Nb}_{0.125} \mathrm{O}_{\mathrm{x}}$

1. Materials chemistry, catalyst preparation
+Precipitation
$\rightarrow$ Nucleation
$\rightarrow$ Crystal growth
-Recrystallization
-Dispersions
-Colloids
+Impregnation/incipient wetness
+Surface charge

## 2. Catalyst

Particle size is related to
$\rightarrow$ Active surface area
$\rightarrow$ Electronic properties
$\rightarrow$ Exposed crystal faces
*Metal-support interaction
$\rightarrow$ Deactivation
$\rightarrow$ Sintering
$\rightarrow$ Coverage

## -Solid state

Particle shape is related to
-Exposed active planes (structure sensitive catalytic reactions)
$\rightarrow$ Particle shape and morphology determine the relative amount of edge and corner atoms

## Examples from literature



Fig. 2. Effects of particle size on the activity of titania-supported Au for the oxidation of CO (5).
M. Valden, X. Lai, D. W. Goodman, Science 281, 1647 (1998).

## Examples from literature

Problem of sintering for catalysts operating at high temperature, e.g., catalysts for
-catalytic combustion of methane
$\rightarrow$ close-coupled automotive exhaust catalysts
$\rightarrow$ steam reforming of methane


Investigation of the sintering mechanism

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A.K. Datye et al., Catalysis Today
111 (2006) 59-67.
```



Particle size distributions after sintering at $900^{\circ} \mathrm{C}$ for differing lengths of time. All data have been fitted using a log normal distribution: $7 \mathrm{wt} . \%$ Pd/alumina

## Examples from literature



Fig. 1. Gruim size as a function of veparszturation/sol.mbility.



## Investigation of the particle formation process during precipitation

free-jet SAXS measurements were taken at a distance of 11.5 and 56.5 cm from the mixing point, which corresponds to residence times of 40 and 200 ms

Fig. 2. Dasign for time-rasolved messuraments on fros-jot maspensions. Onlime SAXS and cryo-TEM experiments for studying pracipitation resctions at time $r_{r}=s / v$.
H. Haberkorn et al., Journal of Colloid and Interface Science 259 (2003) 112.

| Active phase | Bulk materials / colloids |
| :--- | :--- |
| $\rightarrow$ Chemisorption (essentially | $\rightarrow$ Sieving |
| restricted to metal particles) | $\rightarrow$ Sedimentation |
| $\rightarrow$ X-ray diffraction - Line | $\rightarrow$ Light scattering |
| broadening analysis | $\rightarrow$ Acoustic methods |
| (crystallite size) | $\rightarrow$ Time-of flight techniques |
| $\rightarrow$ Small-angle X-ray scattering | $\rightarrow$ Small-angle X-ray |
| (SAXS) (particle size) | scattering |
| $\rightarrow$ Electron microscopy | $\rightarrow$ X-ray diffraction - Line |
|  | broadening analysis |
|  | (crystallite size) |
|  | $\rightarrow$ Elecron microscopy |
|  |  |


| Active phase | Bulk materials / colloids |
| :---: | :---: |
| $\rightarrow$ Chemisorption (essentially restricted to metal particles) <br> $\rightarrow$ X-ray diffraction - Line broadening analysis (crystallite size) <br> -Small-angle X-ray scattering (SAXS) (particle size) <br> $\rightarrow$ Electron microscopy | + Sieving <br> -Sedimentation <br> $\rightarrow$ Light scattering <br> $\rightarrow$ Acoustic methods <br> $\rightarrow$ Time-of flight techniques <br> $\rightarrow$ Small-angle X-ray scattering <br> -X-ray diffraction - Line broadening analysis (crystallite size) <br> $\uparrow$ Elecron microscopy |

Assumptions, if microstructural analysis is not available:
collection of $n_{i}$ particles particles are spherical


Surface area of the spheres
Volume of the spheres

$$
\begin{aligned}
& \mathrm{A}_{\mathrm{i}}=\pi \mathrm{d}_{\mathrm{i}}^{2} \\
& \mathrm{~V}_{\mathrm{i}}=\pi \mathrm{d}^{3} / \mathrm{i}
\end{aligned}
$$

Two mean particle sizes are usually considered:
length-number
volume-area

| $\mathrm{d}_{\mathrm{LN}}$ | $=$ | $\Sigma \mathrm{n}_{\mathrm{i}} \mathrm{d}_{\mathrm{i}} / \Sigma \mathrm{n}_{\mathrm{i}}$ |
| :--- | :--- | :--- |
| $\mathrm{d}_{\mathrm{VA}}$ | $=$ | $6\left(\Sigma \mathrm{n}_{\mathrm{i}} \mathrm{V}_{\mathrm{i}} / \Sigma \mathrm{n}_{\mathrm{i}} \mathrm{A}_{\mathrm{i}}\right)$ |
|  | $=\quad \Sigma \mathrm{n}_{\mathrm{i}} \mathrm{d}^{3} / \Sigma \mathrm{n}_{\mathrm{i}} \mathrm{d}^{2}{ }_{\mathrm{i}}$ |  |
|  |  |  |
| $\mathrm{D}(\%)$ | $=\quad \quad\left(\mathrm{N}_{\mathrm{s}} / \mathrm{N}_{\mathrm{t}}\right) 100$ |  |
| $\mathrm{~N}_{\mathrm{s}}$ | number of surface atoms |  |
| $\mathrm{N}_{\mathrm{t}}$ | total number of atoms <br>  | (bulk and surface) |

$=\quad \Sigma \mathrm{n}_{\mathrm{i}} \mathrm{d}^{3} / \Sigma \mathrm{n}_{\mathrm{i}} \mathrm{d}^{2}{ }_{\mathrm{i}}$
$D(\%)=\left(N_{s} / N_{t}\right) 100$
(fraction of surface atoms)

Number of atoms per unit surface area in the three low index planes of copper
(fcc structure with $a=3.615 \times 10^{-10} \mathrm{~m}$ )


M atomic mass ( $63.55 \mathrm{~g} \mathrm{~mol}^{-1}$ )
$\rho$ density $\left(8.92 \mathrm{~g} \mathrm{~cm}^{-3}\right.$ )
$\mathrm{N}_{\mathrm{A}} 6.022 \times 10^{23} \mathrm{~mol}^{-1}$

| Plane | Surface <br> cell | Area | Area $/ \mathrm{m}^{2}$ | Atoms <br> per cell | Atoms per <br> $\mathrm{m}^{2}$ |
| :--- | :--- | :--- | :--- | :--- | :--- |
| $(111)$ | triangular | $\left(a^{2} \sqrt{ } 3\right) / 2$ | $11.32 \times 10^{-20}$ | 2 | $1.77 \times 10^{19}$ |
| $(100)$ | square | $\mathrm{a}^{2}$ | $13.07 \times 10^{-20}$ | 2 | $1.53 \times 10^{19}$ |
| $(110)$ | rectangular | $\mathrm{a}^{2} \sqrt{ } 2$ | $18.48 \times 10^{-20}$ | 2 | $1.08 \times 10^{19}$ |
| Mean number of atoms per unit area $\mathrm{n}_{\mathrm{s}}$ | $1.46 \times 10^{19}$ |  |  |  |  |

Surface area occupied by a Cu atom
Volume occupied by a Cu atom
Specific surface area

Dispersion

$$
\begin{array}{lll}
\text { If } \mathrm{d}_{\mathrm{VA}}=5 \mathrm{~nm}, & \mathrm{~S}_{\mathrm{sp}}= & 134.5 \mathrm{~m}^{2} \mathrm{~g}^{-1} \\
& \mathrm{D}= & 6\left(\mathrm{v}_{\mathrm{m}} / \mathrm{a}_{\mathrm{m}}\right) / \mathrm{d}_{\mathrm{VA}} \\
\text { If } \mathrm{d}_{\mathrm{VA}}=5 \mathrm{~nm} & \mathrm{D}= & 21 \%
\end{array}
$$

## Metal particles



Plot of dispersion $D$ as a function of mean diameter $\mathrm{d}_{\mathrm{VA}}$ for copper, palladium and gold.



Plot of specific surface area $S_{s p}$ as a function of mean diameter $\mathrm{d}_{\mathrm{VA}}$ for copper, palladium and gold

## Metal particles



$A_{\mathcal{O}}=\sqrt{3} a^{2} \approx 1,73 a^{2}$

$A_{O}=2 \sqrt{3} a^{2} \approx 3,46 a^{2}$

$A_{O}=5 \sqrt{3} a^{2} \approx 8,66 a^{2}$

Clusters of cubic metals


891 atom octahedron
\$Spherical geometry should not be used for particles smaller than ca. 1.2 nm
$\downarrow$ For smaller particles, geometrical models should be considered


1289 atom Wulff polyhedron (minimum energy shape)

Metal particle size measurements
-Chemisorption
$\rightarrow$ X-ray diffraction - Line broadening analysis (crystallite size)
-Small-angle X-ray scattering (SAXS) (particle size)
-Electron microscopy

Exposed surface area (esp. of metals)


Other probes
$\mathrm{O}_{2}, \mathrm{NO}, \mathrm{N}_{2}, \mathrm{H}_{2} \mathrm{~S}$, $\mathrm{CS}_{2}, \mathrm{C}_{6} \mathrm{H}_{6}, \ldots$

## Principle

Formation of an irreversibly, selectively adsorbed monolayer
Stoichiometry of the chemisorption reaction is known

Measurement of the amount adsorbed
+Static methods
$\rightarrow$ Volumetry
$\rightarrow$ Gravimetry
$\rightarrow$ Dynamic methods
$\rightarrow$ Continuous flow
$\rightarrow$ Pulse adsorption
$\rightarrow$ Temperature-programmed desorption / MS

```
S Sp
D (%) = (Vm
Vm
am
n chemisorption stoichiometry
m mass of catalyst (g)
wt metal loading (%)
```


## Complications

-Equilibrium coverage increases with adsorption pressure
*Non-selective chemisorption (chemisorption on the support, spillover)
$\rightarrow$ Reversible chemisorption

$$
\mathrm{N}_{2} \mathrm{O}(\mathrm{~g})+2 \mathrm{Cu}_{\mathrm{s}}{ }^{3} \rightarrow(\mathrm{Cu}-\mathrm{O}-\mathrm{Cu})_{\mathrm{s}}+\mathrm{N}_{2}(\mathrm{~g})
$$

> G.C. Chinchen et al.,
> J. Catal. 103 (1987) 79.
E.D. Batyrev et al., J. Catal. 229 (1) (2005) 136.
M.J. Luys et al., Appl. Catal. 46 (1989) 161.
$\rightarrow$ Chemisorption: Flow of $2 \mathrm{~cm}^{3} / \mathrm{s} 1 \% \mathrm{~N}_{2} \mathrm{O} / 99 \% \mathrm{Ar}$ at 363 K during 50 min *Amount of oxygen consumed was determined from the weight gain of the sample $\downarrow$ Linear extrapolation of the subsurface contribution to $t=0$
$\rightarrow$ Assumtions: $\mathrm{Cu}_{\mathrm{s}} / \mathrm{O}_{\mathrm{ads}}=2,1.46 \times 10^{19} \mathrm{Cu}_{\mathrm{s}}$ atoms $/ \mathrm{m}^{2}$

$\rightarrow$ Increasing the $\mathrm{N}_{2} \mathrm{O}$ concentration, surface oxidation but not subsurface oxidation is increased
-Subsurface oxidation rate increases with temperature (local T during $\mathrm{N}_{2} \mathrm{O}$ chemisorption depends on Cu dispersion as well as thermal properties of the system!)

Continuous flow technique (frontal sorption method)

$$
\mathrm{N}_{2} \mathrm{O}(\mathrm{~g})+2 \mathrm{Cu}_{\mathrm{s}}^{0} \rightarrow(\mathrm{Cu}-\mathrm{O}-\mathrm{Cu})_{\mathrm{s}}+\mathrm{N}_{2}(\mathrm{~g})
$$

$$
\begin{aligned}
& \Delta_{\mathrm{R}} \mathrm{H}=317 \mathrm{~kJ} / \mathrm{mol} \\
& \left(\mathrm{~N}_{2} \mathrm{O}, \mathrm{Cu} / \mathrm{ZnO}\right)
\end{aligned}
$$


$\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}$ catalyst
$\star$ Flow of $10 \mathrm{Nml} / \mathrm{min}$ $1 \% \mathrm{~N}_{2} \mathrm{O} / \mathrm{He}$ at 300 K , $\mathrm{p}=0.1 \mathrm{MPa}, \mathrm{m}_{\text {cat }}=0.2 \mathrm{~g}$ bed height $=20 \mathrm{~mm}$ contact time $=1.4 \mathrm{~s}$ $\Delta$ T approx. 1 K
$\rightarrow$ Determination of $\mathrm{N}_{2}$ formed as product of molar flow and peak area
O. Hinrichsen, T. Genger, and M. Muhler, Chem. Eng. Technol. 23 (2000) 11.

Pulse technique (pulse sorption method)
$\mathrm{N}_{2} \mathrm{O}(\mathrm{g})+2 \mathrm{Cu}_{\mathrm{s}}{ }^{3} \rightarrow(\mathrm{Cu}-\mathrm{O}-\mathrm{Cu})_{\mathrm{s}}+\mathrm{N}_{2}(\mathrm{~g})$


Injection of successive small pulses of known volume into the flow of an inert gas
$\rightarrow$ Flow of $20 \mathrm{Nml} / \mathrm{min} \mathrm{He}$ $\mathrm{V}=1.0 \mathrm{ml} \mathrm{N}_{2} \mathrm{O}$
$\mathrm{T}=300 \mathrm{~K}$ $\mathrm{p}=0.1 \mathrm{MPa}$
*\#66 $=125 \mu \mathrm{~mol} / \mathrm{g} \mathrm{N}_{2}$
$\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}$ catalyst
O. Hinrichsen, T. Genger, and M. Muhler, Chem. Eng. Technol. 23 (2000) 11.

$$
\mathrm{H}_{2}(\mathrm{~g})+2 \mathrm{Cu}_{\mathrm{s}}^{0} \rightarrow(\mathrm{Cu}-\mathrm{H}-\mathrm{Cu})_{\mathrm{s}}
$$


$\rightarrow$ Saturation with $\mathrm{H}_{2}$ at 1.5 MPa, T=240K, cooling down in $\mathrm{H}_{2}$ flow to 78 K , purging with He
+TPD:
Flow He $100 \mathrm{Nml} / \mathrm{min}$ heating rate $6 \mathrm{~K} / \mathrm{min}$
$\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}$ catalyst
M.Muhler et al., Catal. Lett. 14
(1992) 241.
O. Hinrichsen, T. Genger, and M. Muhler
Chem. Eng. Technol. 23 (2000) 11.

| Sequence of <br> experiment | Amount of <br> desorbed $N_{2}$ or <br> $\mathrm{H}_{2}(\mu \mathrm{~mol} / \mathrm{g})$ | Specific Cu metal <br> surface area <br> $\left(\mathrm{m}^{2} / \mathrm{g}\right)$ |
| :--- | :--- | :--- |
| $\mathrm{H}_{2}$ TPD | 115 | 18.8 |
| $1 \% \mathrm{~N}_{2} \mathrm{O}$ RFC | 217 | 17.8 |
| $\mathrm{H}_{2}$ TPD | 115 | 18.8 |

-Convenient method for routine measurements
$\rightarrow$ Chemisorption probes the exposed surface $=$ surface relevant for catalysis
$\rightarrow$ Measured surface areas depend on the catalyst pretreatment
-Absolute value of particle size involves many assumptions

## Recommendations

Minimization of
$\rightarrow$ Reversible chemisorption
$\rightarrow$ Chemisorption at the support
$\rightarrow$ Reactive chemisorption
By application of proper operating conditions, established by other methods (TPD, FTIR)
$\rightarrow$ Chemisorption of different probe molecules
$\rightarrow$ Investigation of the catalyst with additional/complementary methods helps to avoid misinterpretation of the chemisorption results

Crystallite size (from 1.5-2 nm to 100 nm )
Breadth of a X-ray reflection depends upon
$\rightarrow$ Size of the crystallite

- Defects in the lattice (microstrains or stacking faults)
- Instrumental factors (slit witdth, sample size, penetration of the beam,...)

| The Scherrer Formula |  |  |
| :---: | :---: | :---: |
| $\mathrm{L}_{\mathrm{hkl}}=\mathrm{k} \lambda /\left(\mathrm{\beta} \cos \theta_{0}\right)$ | $\mathrm{L}_{\text {hkl }}$ | thickness of the crystallite in the direction perpendicular to the diffracting planes ( $h k /$ ) |
|  | k | shape factor; $\mathrm{k}=1$ (integral); (0.9 for $\beta_{1 / 2}$ ) |
|  | $\lambda$ | wavelength of the diffraction line |
|  | $\beta$ | breadth of the diffraction profile in radians |
|  | $\theta_{0}$ | angular position of the peak maximum |

## Complete Line Profile Analysis

1. Correction for the effects of instrumental broadening
2. Separation between size and strain broadening
3. Derivation of size parameters

For further information, see X-ray diffraction lecture, F. Girgsdies, 20/10/06

## Limitations of LBA

- Overlap of different diffraction lines (e.g., reflections from different phases, neighboring reflections of fcc metals are overlapping when the crystals become very small)
$\rightarrow$ Lack of contrast between the intensity of reflections and that of overall scattering, particulary for metals with low atomic number
$\rightarrow$ Upper limit: Broadening of the signal due to crystallite size becomes too small with respect to the instrumental broadening
- Crystallite size is not necessarily particle size
$\rightarrow$ LBA is a bulk analysis !

|  | $\begin{gathered} \mathbf{S}_{\mathrm{Cu}-\mathrm{RFC}} \\ {\left[\mathrm{~m}^{2} / \mathbf{g}_{\mathrm{cat}}\right]} \end{gathered}$ | $\begin{aligned} & \mathbf{S}_{\mathrm{cu}-} \text { XRD } \\ & {\left[\mathrm{m}^{2} / \mathbf{g}_{\mathrm{cat}}\right]} \end{aligned}$ |
| :---: | :---: | :---: |
| $\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}-1$ | 17,53 +/-1,47 | 17,2 |
| $\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}-2$ | 5,26 | 20,1 |
| $\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}-3$ | 8,27 | 16,3 |
| $\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}-4$ | 5,72 | 14,4 |
| $\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}-5$ | 8,02 | 17,9 |
| $\mathrm{Cu} / \mathrm{ZnO} / \mathrm{Al}_{2} \mathrm{O}_{3}-6$ | 4,78 | 14,2 |
| $\mathrm{Cu} / \mathrm{ZnO-1}$ | 13,13 | 30,5 |
| $\mathrm{Cu} / \mathrm{ZnO}-2$ | 22,07 | 22,9 |

RFC: 1 vol- $\% \mathrm{~N}_{2} \mathrm{O}$ (He), flow: $10 \mathrm{ml} / \mathrm{min}$, temperature: $30^{\circ} \mathrm{C}$, sample: $\mathrm{m}_{\text {cat }}=12 \mathrm{mg}+100 \mathrm{mg}$ BN

Cu crystallite size


Size of Cu (111) and Cu (200) crystal planes from the XRD spectra of $\mathrm{Cu} / \mathrm{SiO}_{2}$ (solid symbols) from the XRD spectra of $\mathrm{Cu} / \mathrm{SiO}_{2}$ ( solid symbol
and $\mathrm{Cu} / \mathrm{ZnO} / \mathrm{SiO}_{2}$ (open symbols) catalysts at increasing reduction temperature. Assignment: triangles for Cu (111), circles for Cu (200).

$$
\mathrm{N}_{2} \mathrm{O}(\mathrm{~g})+2 \mathrm{Cu}_{\mathrm{s}}^{0} \rightarrow(\mathrm{Cu}-\mathrm{O}-\mathrm{Cu})_{\mathrm{s}}+\mathrm{N}_{2}(\mathrm{~g})
$$



Equivalent metal surface area of the ZnO -promoted catalyst (triangles) and unpromoted catalyst (circles) as a function of the reduction temperature.
The $\mathrm{ZnO} / \mathrm{SiO}_{2}$ reference is also included (squares).
$\rightarrow$ Powerful technique for understanding the properties of heterogeneous catalysts
$\rightarrow$ Practical industrial catalysts can be directly examined in an electron microscope
-Atomic resolution images (exposed faces, structural defects, surface atomic structure)
$\rightarrow$ Diffraction patterns from nanometer regions
$\rightarrow$ Nanometer-scale spectroscopy - elemental composition, electronic structure, oxidation state (EELS, XEDS, AES, ...)

## Limitations

$\rightarrow$ Results generally have poor statistical value, due to the high spatial resolution
+Supported metal catalyst: approx. $1 \times 10^{9}$ metal particles per $\mathrm{cm}^{3}$
-Accurate determination of size distribution is difficult -high-throughput image analyzers are needed +Sample preparation $\rightarrow$ UHV / beam damage

For further information, see EM lectures, R.Tesche, 19/01/07 D.S.Su, 26/01/07


Combination of methods for characterization of Cu catalysts

|  | Cu lattice spacing <br> $[\AA]$ | Cu lattice strain <br> $[\%]$ | $\mathrm{D}_{v} \mathrm{Cu}^{0}$ <br> $[\mathrm{~nm}]$ | $\mathrm{Cu}-\mathrm{S}_{0}$ <br> $\left[\mathrm{~m}^{2} / \mathrm{g}\right]$ <br> $-\mathrm{XRD}-$ | $\mathrm{Cu} \mathrm{S}_{\circ}$ <br> $\left[\mathrm{m}^{2} / \mathrm{g}\right]$ <br> $-\mathrm{TEM}-$ | RFC $\left[\mathrm{m}^{2} / \mathrm{g}\right]$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Cat-1 | 3.619 | 0.0123 | 5.2 | 31.0 | 24.0 | - |
| Cat-2 | 3.618 | 0.0110 | 5.8 | 26.9 | - |  |
| Cat-3 | 3.618 | 0.0110 | 5.8 | 26.9 | 24.5 | 32 |
| Cat-4 | 3.618 | 0.0137 | 3.8 | 41.4 | 23.2 | - |
| Cat-5 | 3.616 | 0.0150 | 4.2 | 37.1 | 26.7 | - |
| Cat-6 | 3.618 | 0.0152 | 4.3 | 36.8 | 27.1 | - |
| Cat-7 | 3.618 | 0.0128 | 5.0 | 31.4 | 24.7 | - |


| Active phase | Bulk materials / colloids |
| :---: | :---: |
| $\rightarrow$ Chemisorption (essentially restricted to metal particles) <br> $\rightarrow$ X-ray diffraction - Line broadening analysis (crystallite size) <br> $\rightarrow$ Small-angle $X$-ray scattering (SAXS) (particle size) <br> $\downarrow$ Electron microscopy | +Sieving <br> -Sedimentation <br> $\rightarrow$ Light scattering <br> -Acoustic methods <br> $\rightarrow$ Time-of flight techniques <br> -Small-angle X-ray scattering <br> $\rightarrow$ X-ray diffraction - Line broadening analysis (crystallite size) <br> $\rightarrow$ Elecron microscopy |

"Sieving is the Cinderella (Aschenputtel) of particle size analyzing methods."
H. Heywood, Proc. Particle size Anal. Conf., Bradford, Soc. Anal. Chem, 186 (1970) 1.

Mesh size $=$ number of wires per linear inch

| sieve <br> designation <br> standard | sieve <br> designation <br> alternate <br> "mesh" | nominal <br> sieve <br> opening <br> (in.) | nominal <br> wire <br> diameter <br> (mm) |
| :---: | :---: | :---: | :---: |
| 125 mm | 5 | 5 | 8 |
| 75 mm | 3 | 3 | 6.3 |
| 63 mm | $21 / 2$ | 2.5 | 5.6 |
| 53 mm | 2.12 | 2.12 | 5 |
| 50 mm | 2 | 2 | 5 |
| 2 mm | No. 10 | 0.0787 | 0.9 |
| 1 mm | No. 18 | 0.0394 | 0.56 |
| $850 \mu \mathrm{~m}$ | No. 20 | 0.0331 | 0.5 |
| $500 \mu \mathrm{~m}$ | No. 35 | 0.0197 | 0.315 |
| $150 \mu \mathrm{~m}$ | No. 100 | 0.0059 | 0.1 |
| $53 \mu \mathrm{~m}$ | No. 270 | 0.0021 | 0.036 |
| $20 \mu \mathrm{~m}$ | No. 635 | 0.0008 | 0.02 |

-Hard work, but simple and inexpensive
$\rightarrow$ Important for accuracy and reproducibility
$\rightarrow$ Calibration with a calibration powder
$\rightarrow$ Standard operating procedures should be adopted

T. Allen, Particle Size

Measurement, Volume 1, Powder
sampling and particle size
measurement methods,
Chapmann \& Hall, London 1997.

Particle sizing by measurement of settling velocity

Classification
I. According to the position of theparticles at the beginning of the measurement
a) Homogeneous methods

b) Line-start methods
II. Place of quantity measurement
a) Incremental methods (thin layer)
b) Cumulative methods
III. Force field
a) Gravitational methods
b) Centrifugal methods ( $\mathrm{d}<1 \mu \mathrm{~m}$ )
IV. Measurement principle
a) Gravimetric
b) Absorption of electromagnetic radiation

c) Suspension density
C. Bernhardt, Particle Size Analysis, Classification and Sedimentation methods, Chapmann \& Hall, London 1994.


## Static light scattering (Laser diffraction)



Measurement of time-averaged intensity of scattered light
$\rightarrow$ Rayleigh scattering $d<\lambda / 20$
$\mathrm{I}_{\mathrm{s}}=(8 / 3) \pi \mathrm{I}_{0}\left(2 \pi / \lambda_{0}\right)^{4} \alpha^{2}$
$\rightarrow$ Mie scattering $\mathrm{d} \geq \lambda / 20$
Multiple photon scattering at the particle $\rightarrow$ interference $\rightarrow$ angular dependende of the sample scattering intensity and between particles and continuum (solvent)

## Dynamic light scattering

Measures Brownian motion and relates this to the size of the particles

## From Laser

The particles are moving due to Brownian motion

The correlation is reducing with time Time scale: nanoseconds or microseconds


Speckle pattern
The scattered light falling on the detector.

Average Average
intensity


## Dynamic Light Scattering (DLS)

Correlation $=$ degree of similarity between the intensity at t and $(\mathrm{t}+\delta \mathrm{t})$


The relationship between the size of a particle and its speed due to Brownian motion is given by the Stokes-Einstein equation

The rate of decay for the correlation function is related to the particle size

$$
D_{0}=\frac{k T}{6 \pi \eta R}
$$

$D=$ Diffusion coefficient
$\mathrm{k}=$ Boltzmann constant
$\mathrm{T}=$ absolute temperature
$\eta=$ dynamic viscosity of the solvent
$R=$ radius of the particle

## DLS - precipitation of CuZn hydroxycarbonates



## DLS - precipitation of CuZn hydroxycarbonates

5h sedimentation


## Dynamic Light Scattering (DLS)

## Limitations

$\rightarrow$ Only diluted suspensions can be measured to prevent multiple scattering of the light after scattered off the particle
$\rightarrow 173^{\circ}$ detection optics - backscatter detection
(Zetasizer Nano ZS) reduces multiple scattering

$\rightarrow$ Implementation of Diffusing Wave Spectroscopy (DWS) analysis of autocorrelation functions from multiply scattered light
-Analysis of concentrated suspensions using fiber-optic probes
$\rightarrow$ Discremination between primary particles and agglomerates not possible

## Acoustic methods


http://www.quantachrome.de/messmethoden/index_partikelgroessenbestimmung.html

## Small-Angle $\underline{X}$-ray Scattering Analysis (SAXS)

Mean particle size (from 1 nm to 100 nm ), specific surface area and particle shape

Principle:
Scattering of X-rays by small domains of uniform matter (crystalline or amorphous), for which the electron density $\rho^{e}$ is different from the continuous medium


## Small-Angle $\underline{X}$-ray Scattering Analysis (SAXS)



Thin monochromatic X-ray beam
Synchrotron radiation
Neutrons
H.-D. Dörfler, Grenzflächen- und Kolloidchemie, VCH, Weiheim, 1994.

## Small-Angle X-ray Scattering Analysis (SAXS)

The central peak scattered intensity gets broader as the domain size (particles, voids) decreases
SAXS parameters (mean size / size distribution / specific surface area) are derived from analysis of the profile of the SAXS curve
I(s) scattered intensity $s$ scattering vector $s=(2 \sin \theta) / \lambda \approx 2 \theta / \lambda$
Guinier
In case of dilute system and identical particle shape the SAXS curve can be represented by an exponetial approximation:

$$
I(s)=\left(\rho_{1}^{e}-\rho_{2}^{e}\right)^{2} V^{2} \exp \left(-4 \pi^{2} s^{2} R_{G}^{2} / 3\right)
$$

$R_{\mathrm{G}} \quad$ radius of gyration $=$ radius of a hypothetical sphere around the center of symmetry
$V \quad$ volume of the domain Relation between $R_{G}$ and the dimension of regular solids: $R_{G}{ }^{2}=(3 / 5) R^{2}$
$R \quad$ radius of a sphere
$\mathrm{H}_{2} \mathrm{SO}_{4}+2 \mathrm{Na}\left[\mathrm{Al}(\mathrm{OH})_{4}\right] \rightarrow 2 \mathrm{AlOOH}+\mathrm{Na}_{2} \mathrm{SO}_{4}+4 \mathrm{H}_{2} \mathrm{O}$
starting solutions:
Educt $\mathrm{A}: \mathrm{Na}\left[\mathrm{Al}(\mathrm{OH})_{4}\right]+\mathrm{NaOH}$ in $\mathrm{H}_{2} \mathrm{O}(\mathrm{pH}$ 13.5)
Educt B: $\mathrm{H}_{2} \mathrm{SO}_{4}(0.5 \mathrm{~mol} / \mathrm{l})$
$\mathrm{T}=65^{\circ} \mathrm{C}, \mathrm{pH} 9$, solid concentration of boehmite of about $1.5 \%$ by weight


Fig. 17. Online and offline SAXS results on free-jet and on ripened suspensions. Effect of the residence and ripening time $t_{r}$ on the coherence lengths $l_{c}$ and $l_{c}^{*}$ (standard precipitation conditions).
H. Haberkorn et al., Journal of Colloid and Interface Science 259 (2003) 112.

## Advantages of SAXS

$\rightarrow$ The method can be used for analysis of powders in either dry state or when suspended in a dispersing medium
$\rightarrow$ Little interference due to multiple scattering in dispersions with high solids concentrations
$\rightarrow$ Sensitive to the presence of agglomerates, hence, the technique can be used to distiguish primary particles from agglomerates and in some cases the morphology of the agglomerates
$\rightarrow$ Complementary to LBA
No routine analysis!

## Heterogeneous catalysis


$\rightarrow$ The diversity of particles sizes (from mm to nm) and states of aggregation (solid, liquid, gaseous) account for a large variety of particle size measurement methods.
$\rightarrow$ A combination of two or more methods would be necessary to obtain an unambiguous evaluation of particle size.
-Size distribution,
-Spatial distribution (accessibility/ phase interaction) and
+Particle shape / microstructure are more critical for the performance of a catalysts than the mean particle size.

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